



SCA3000-E05 3-AXIS ULTRA LOW POWER ACCELEROMETER WITH DIGITAL SPI INTERFACE

Features

- 2.35 V 3.6 V supply voltage,
 1.7 3.6 V digital I/O voltage
- ±18 g measurement range
- · SPI digital interface
- Selectable frequency response
- Ultra low power consumption (2.5 V, 120 μA typ)
- 64 samples/axis buffer memory for output acceleration data and advanced features enable significant power and resource savings at system level
- Interrupt signal triggered by motion
- Size 7x7x1.8 mm
- · Proven capacitive 3D-MEMS technology
- · High shock durability
- · RoHS compliant / lead free soldering

Applications

SCA3000-E05 is targeted to battery operated wrist and hand-held devices. Typical applications are but not limited

• Sports equipment

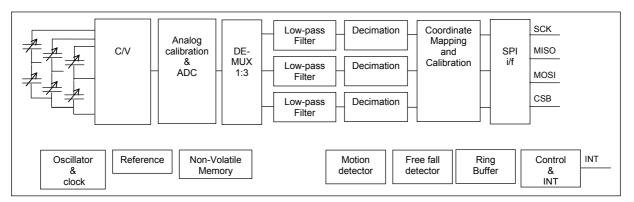


Figure 1 SCA3000-E05 Block Diagram



Performance Characteristics 1)

Analog and digital Vdd Vdd ≥ Digital I/O Vdd 1.7 1.8 / 2.5 2.7 - 3.3 - V Digital I/O Vdd Vdd ≥ Digital I/O Vdd 1.7 1.8 / 2.5 2.7 - 3.3 - V Operating temperature **	Parameter	Condition	Typical supply range 2.35 – 2.7 V			Extended supply range 2.7 – 3.6 V			Units
Analog and digital Vdd			Min	Typ ²⁾	Max	Min	Typ 2)	Max	
Digital I/O Vdd	Analog and digital Vdd	ı	2.35		2.7	_		-	V
Current consumption * Reset 3) - < 7 12 - < 9 - μA Active Motion Detection - 120 145 - 150 - μA mude Acceleration range * 40 Mominal mode Nominal -18 - 18 - ± 18 - g Offset calibration error * Z-axis + 19 position 300 - 300 - ±500 - mg Offset temperature error ** 50 -2 - 30 ±5.0 +30 - ±5.0 - mg/°C Sensitivity calibration error * -10 - 160 - - 160 - Count/g Sensitivity calibration error * -11 - +11 - ±2 - % Sensitivity calibration error * -11 - +11 - ±5.0 - mg/°C Sensitivity calibration error * -11 - +11 - ±5.0 - 100 - 50.015 - 100.015 - ***	Digital I/O Vdd	Vdd ≥ Digital I/O Vdd	1.7	1.8 / 2.5	2.7	-	3.3	-	V
Current consumption * Reset 3) - < 7 12 - < 9 - μA Active Motion Detection - 120 145 - 150 - μA mude Acceleration range * 40 Mominal mode Nominal -18 - 18 - ± 18 - g Offset calibration error * Z-axis + 19 position 300 - 300 - ±500 - mg Offset temperature error ** 50 -2 - 30 ±5.0 +30 - ±5.0 - mg/°C Sensitivity calibration error * -10 - 160 - - 160 - Count/g Sensitivity calibration error * -11 - +11 - ±2 - % Sensitivity calibration error * -11 - +11 - ±5.0 - mg/°C Sensitivity calibration error * -11 - +11 - ±5.0 - 100 - 50.015 - 100.015 - ***	Operating temperature **	<u> </u>	-40	-	85	-40	-	85	°C
Motion Detection mode	Current consumption *	Reset 3)	-	<7	12	-	<9	-	μΑ
Motion Detection mode		Active	-	120	145	-	150	-	μA
Offset calibration error * Z-axis +1g position			-	120	145	-	150	-	· - ·
Offset calibration error * Z-axis +1g position	Acceleration range * 4)	Nominal	-18	-	18	-	± 18	-	g
Sensitivity * 6	Offset calibration error *	Z-axis +1g position	-300	-	300	-	± 500	-	
Sensitivity calibration error *	Offset temperature error ** 5)	-40 +85 °C	-30		+30	-		-	mg/°C
Sensitivity temperature error -40 +85 °C -0.05 ±0.015 0.05 - ±0.015 -	Sensitivity * ⁶⁾		-	160	-	-	160	-	
Non-Linearity ** 8) Cross-Axis sensitivity ** 9) Bandwidth ** 10) Measurement mode	Sensitivity calibration error *			-		-		-	
Cross-Axis sensitivity ** *9) Bandwidth ** *10) Measurement mode Narrow band 7 9 11 - 9 - Hz Marrow band 7 9 11 - 9 - Hz Measurement mode Wide band 50 75 100 - 70 - Hz Measurement mode Narrow band - 50 100 - 50 - mg RMS Marrow band - 22 44 - 22 - mg RMS Measurement mode Wide band - 65 130 - 65 - mg RMS Measurement mode Wide band 40 50 60 - 45 - Hz Measurement mode Wide band 40 50 60 - 45 - Hz Measurement mode Wide band - 200 400 - 200 - Hz Turn on time ** *12) Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 40 - 20 - ms Measurement mode Wide band - 200 40 - 20 - ms Measurement mode Wide band - 200 40 - 20 - ms Measurement mode Wide band - 200 40 - 20 - ms Measurement mode Wide band - 20 40 - 20 - ms	** 7)	-40 +85 °C	-0.05	±0.015	0.05	-	±0.015	-	%/°C
Cross-Axis sensitivity ** *9) Bandwidth ** *10) Measurement mode Narrow band 7 9 11 - 9 - Hz Marrow band 7 9 11 - 9 - Hz Measurement mode Wide band 50 75 100 - 70 - Hz Measurement mode Narrow band - 50 100 - 50 - mg RMS Marrow band - 22 44 - 22 - mg RMS Measurement mode Wide band - 65 130 - 65 - mg RMS Measurement mode Wide band 40 50 60 - 45 - Hz Measurement mode Wide band 40 50 60 - 45 - Hz Measurement mode Wide band - 200 400 - 200 - Hz Turn on time ** *12) Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 400 - 200 - ms Measurement mode Wide band - 200 40 - 20 - ms Measurement mode Wide band - 200 40 - 20 - ms Measurement mode Wide band - 200 40 - 20 - ms Measurement mode Wide band - 200 40 - 20 - ms Measurement mode Wide band - 20 40 - 20 - ms	Non-Linearity ** 8)		-3	±1	3	-	±1	-	% FS
Bandwidth ** 10)	Cross-Axis sensitivity ** 9)		-	±4	-	-	±4	-	%
Measurement mode Wide band So T5 100 - T0 - Hz	Bandwidth ** 10)	Measurement mode	45	60	75	-	60	-	Hz
Measurement mode Noise ** 11) Measurement mode -			-			-		-	Hz
Narrow band			50	75	100	-		-	
Measurement mode Wide band reasurement mode Wide band measurement mode Measurement mode Measurement mode Measurement mode Measurement mode Measurement mode Mide band Measurement mode Mide band Measurement mode Mide band Measurement mode Mide band Measurement mode Measure	Noise ** 11)	Measurement mode	-			-		-	
Output data rate **			-	22	44	-	22	-	
Narrow band 40 50 60 - 45 - Hz measurement mode Wide band 320 400 480 - 400 - Hz measurement mode Turn on time ** 12) Measurement mode - 30 60 - 30 - ms Narrow band - 200 400 - 200 - ms measurement mode Wide band - 20 40 - 20 - ms measurement mode Output load ** Output load **						-		-	mg RMS
Measurement mode	Output data rate **	Measurement mode				-		-	
measurement mode Turn on time ** ¹²⁾ Measurement mode - 30 60 - 30 - ms Narrow band - 200 400 - 200 - ms measurement mode Wide band - 20 40 - 20 - ms measurement mode Output load ** Output load **					60	-		-	Hz
Narrow band - 200 400 - 200 - ms measurement mode Wide band - 20 40 - 20 - ms measurement mode Output load ** Narrow band - 200 400 - 200 - ms ms measurement mode			320	400	480	-	400	-	Hz
Wide band - 20 40 - 20 - ms measurement mode Output load ** - 35 - 35 pF	Turn on time ** ¹²⁾	Narrow band	-					-	
Output load ** 35 35 pF		Wide band	-	20	40	-	20	-	ms
	Output load **		-	-	35	-	-	35	pF
	SPI clock rate **		-	-		-	-		

- * 100% tested in production
- ** Qualified during product validation
- The product is factory calibrated at 2.5 V in room temperature.
- Typical values are not guaranteed.
- Includes the current through the internal 400 kΩ pull-up resistor connected to digital I/O Vdd.
- Range defined as $\sqrt{x^2+y^2+z^2} \le 18g$. The measuring range is tested on sensing element level. FS = 18g.
- Offset temperature error = {Count(0g)-Offset} / Sensitivity [g]. Sensitivity = Calibrated sensitivity. Offset= Calibrated offset.
- Sensitivity = {Count(+1g) Count(-1g)}/2 [Count/g].
- Sensitivity temperature error = {[Count(+1g)-Count(-1g)]/2 Sensitivity x 100% [%]. Sensitivity = Calibrated sensitivity.
- From straight line through sensitivity calibration (+1g, -1g) points.
- The cross-axis sensitivity determines how much acceleration, perpendicular to the measuring axis, couples to the output. The total cross-axis sensitivity is the geometric sum of the sensitivities of the two axes which are perpendicular to the measuring axis. The angular alignment error between X, Y and Z axis is included into the cross axis sensitivity.
- Frequency responses according to Figure 3, Figure 4 and Figure 5.



- Average noise/axis over the measurement bandwidth defined as $\sqrt{\frac{1}{3}(n_x^2+n_y^2+n_z^2)}$, where nx, ny and nz are
- the measured signal's standard deviation due to noise in x, y and z directions.

 Settling error less than 1% of FS.

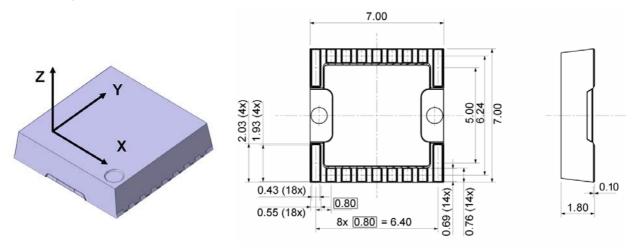


Figure 2 Sensing directions and package dimensions in mm with ±50 µm tolerance.

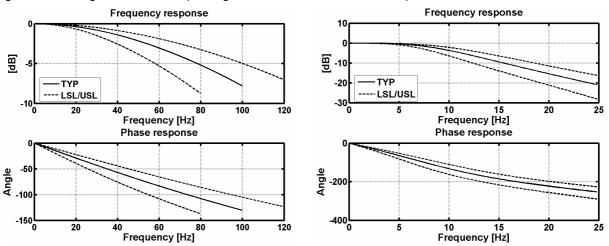


Figure 3 Frequency response of SCA3000-E05 in measurement mode

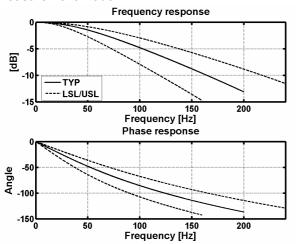


Figure 5 Frequency response of SCA3000-E05 in wide band measurement mode

Figure 4 Frequency response of SCA3000-E05 in narrow band measurement mode



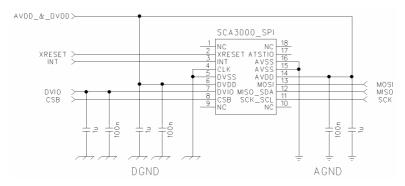


Figure 6 Application schematic

Pin#	Name	Function
1	NC	Not connected
2	XRESET	External reset, active low
3	INT	Interrupt output
4	CLK	Digital ground
5	DVSS	Digital ground
6	DVDD	Digital supply
7	DVIO	Digital I/O supply
8	CSB	Chip select
9	NC	Not connected
10	NC	Not connected
11	SCK_SCL	SPI serial clock (SCK)
12	MISO_SDA	SPI data out (MISO)
13	MOSI	SPI data in (MOSI)
14	AVDD	Analog supply
15	AVSS	Analog ground
16	AVSS	Analog ground
17	ATSTIO	Not connected
18	NC	Not connected

Table 1 Pin descriptions

Document Change Control

Rev.	Date	Change Description
0.1	11-Aug-06	First version
0.2	26-Oct-06	Frequency responses updated
0.3	04-Jan-07	Offset and sensitivity temperature dependencies updated. Turn-on time and noise characteristics added.
Α	08-Feb-07	1 st official release
A.01	31-Oct-07	Figure 2 updated
В	28-Aug-08	Performance characteristics updated

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